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CONFIRMATION NO. 8919

| SERIAL NUMBER | FILING or 371(c) DATE | CLASS | GROUP ART UNIT | ATTORNEY DOCKET NO. |
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APPLICANTS

Frederick Ware, Los Altos Hills, CA;
 Scott Best, Palo Alto, CA;
 Timothy Chang, Saratoga, CA;
 Richard Perego, San Jose, CA;
 Ely Tsern, Los Altos, CA;
 Jeff Mitchell, Santa Clara, CA;

**** CONTINUING DATA *******

This appln claims benefit of 60/450,007 02/26/2003

**** FOREIGN APPLICATIONS *********** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ****

06/15/2004

| Foreign Priority claimed 35 USC 119(a-d) conditions met | <input type="checkbox"/> Yes <input checked="" type="checkbox"/> No | <input type="checkbox"/> Met after QT Initials | STATE OR COUNTRY | SHEETS DRAWINGS | TOTAL CLAIMS | INDEPENDENT CLAIMS |
|--|---|--|---------------------|--------------------|-----------------|-----------------------|
| Verified and Acknowledged /TRUNG Q NGUYEN/ Examiner's Signature | | | CA | 50 | 14 84 | 1 10 |

ADDRESS

DENIRO/RAMBUS
 575 MARKET STREET
 SUITE 2500
 SAN FRANCISCO, CA 94105
 UNITED STATES

TITLE

Method and apparatus for test and characterization of semiconductor components

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|------------------------------------|---|--|
| FILING FEE RECEIVED 4270 | FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following: | <input type="checkbox"/> All Fees |
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